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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/649,124	SAIKA ET AL.	
Examiner	Art Unit	
Michael I e	2163	

SEARCHED				
Class	Subclass	Date	Examiner	
707	104.1,204	2/11/2006	ML	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Inventor Name Search	2/11/2006	ML		
Updated EAST search	2/11/2006	ML		
Updated Partial Classification Search	2/11/2006	ML		
Updated NPL Search (ACM, Google)	2/11/2006	ML		
Searched EAST with key words and concepts	2/11/2006	ML		